IDT™

FEMTOCLOCKS™ CRYSTAL-TO-3.3V LVPECL FREQUENCY SYNTHESIZER

ICS8430252-45

## GENERAL DESCRIPTION

ICS
HiPerClockS™

The ICS8430252-45 is a 2 output LVPECL and LVCMOS/LVTTL Synthesizer optimized to generate Ethernet reference clock frequencies and is a member of the HiPerClocks™ family of high performance clock solutions from IDT. Using a 25MHz, 18pF parallel resonant crystal, the following frequencies can be generated: 156.25MHz LVPECL output and, 125MHz LVCMOS output. The 8430252-45 uses IDT's 3rd generation low phase noise VCO technology and can achieve 1ps or lower typical rms phase jitter, easily meeting Ethernet jitter requirements. The ICS8430252-45 is packaged in a small 16-pin TSSOP package.

FEATURES

- One differential 3.3V LVPECL output and One LVCMOS/LVTTL output

- Crystal oscillator interface designed for a 25MHz, 18pF parallel resonant crystal

- A 25MHz crystal generates both an output frequency of 156.25MHz (LVPECL) and 125MHz (LVCMOS)

- VCO frequency: 625MHz

- RMS phase jitter @ 156.25MHz (1.875MHz - 20MHz) using a 25MHz crystal: 0.39ps (typical)

- Full 3.3V supply mode

- 0°C to 70°C ambient operating temperature

- Available in both standard (RoHS 5) and lead-free (RoHS 6) packages

BLOCK DIAGRAM
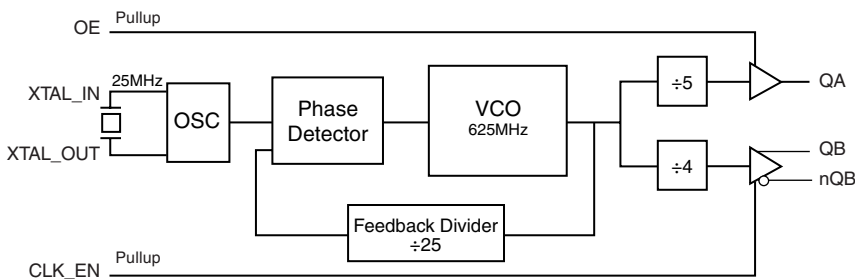
PIN ASSIGNMENT

ICS8430252-45
16-Lead TSSOP
4.4mm x 5.0mm x 0.92mm
package body
G Package
Top View

TABLE 1. PIN DESCRIPTIONS

Number	Name	Type		Description
1	OE	Input	Pullup	Output enable pin. LVCMOS/LVTTL interface levels. See Table 3A Function Table.
2, 9, 15	V_{EE}	Power		Negative supply pin.
3	QA	Output		LVCMOS/LVTTL clock output.
4	V_{CCO_A}	Power		Output supply pin for QA output.
5, 6	nc	Unused		No connect.
7	V_{CCA}	Power		Analog supply pin.
8	V_{CC}	Power		Core supply pin.
10, 11	XTAL_OUT, XTAL_IN	Input		Crystal oscillator interface. XTAL_IN is the input, XTAL_OUT is the output.
12	V_{CCO_B}	Power		Output supply pin for QB, nQB outputs.
13, 14	nQB, QB	Output		Differential clock outputs. LVPECL interface levels.
16	CLK_EN	Input	Pullup	Clock enable pin. LVCMOS/LVTTL interface levels. See Table 3B Function Table.

TABLE 2. PIN CHARACTERISTICS

Symbol	Parameter	Test Conditions		Minimum	Typical	Maximum	Units
C_{IN}	Input Capacitance				4		pF
C_{PD}	Power Dissipation Capacitance	V_{CC}, V_{CCA}, $V_{CCO\_A,}$ V_{CCO_B} = 3.465V			18		pF
R_{PULLUP}	Input Pullup Resistor				51		kΩ
R_{OUT}	Output Impedance	QA	V_{CCO_A} = 3.3V		20		Ω

TABLE 3A. OE SELECT FUNCTION TABLE

Input	Output
OE	QA
0	Hi-Z
1	Active

TABLE 3B. CLK_EN SELECT FUNCTION TABLE

Input	Outputs	
CLK_EN	QB	nQB
0	Low	High
1	Active	Active

ABSOLUTE MAXIMUM RATINGS

Supply Voltage, V_{CC}	4.6V
Inputs, V_I	-0.5V to V_{CC} + 0.5V
Outputs, I_O	
Continuous Current	50mA
Surge Current	100mA
Package Thermal Impedance, θ_{JA}	89°C/W (0 lfpm)
Storage Temperature, T_{STG}	-65°C to 150°C

NOTE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

TABLE 4A. POWER SUPPLY DC CHARACTERISTICS, $V_{CC} = V_{CCA} = V_{CCO\_A,} V_{CCO\_B} = 3.3V\pm5\%$, $T_A = 0°C$ TO 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{CC}	Core Supply Voltage		3.135	3.3	3.465	V
V_{CCA}	Analog Supply Voltage		V_{CC} – 0.10	3.3	V_{CC}	V
V_{CCO_A}, V_{CCO_B}	Output Supply Voltage		3.135	3.3	3.465	V
I_{EE}	Power Supply Current				95	mA
I_{CCA}	Analog Supply Current				10	mA

TABLE 4B. LVCMOS / LVTTL DC CHARACTERISTICS, $V_{CC} = V_{CCA} = V_{CCO\_A} = 3.3V\pm5\%$, $T_A = 0°C$ TO 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
V_{IH}	Input High Voltage			2		V_{CC} + 0.3	V
V_{IL}	Input Low Voltage			-0.3		0.8	V
I_{IH}	Input High Current	OE, CLK_EN	$V_{CC} = V_{IN} = 3.465V$			5	
I_{IL}	Input Low Current	OE, CLK_EN	$V_{CC} = 3.465V$, $V_{IN} = 0V$	-150			
V_{OH}	Output High Voltage; NOTE 1			2.6			V
V_{OL}	Output Low Voltage; NOTE 1					0.5	V

NOTE 1: Outputs terminated with 50Ω to V_{CCO_A}/2. See Parameter Measurement Information Section, "3.3V Output Load Test Circuit".

TABLE 4C. LVPECL DC CHARACTERISTICS, $V_{CC} = V_{CCA} = V_{CCO\_B} = 3.3V\pm5\%$, $T_A = 0°C$ TO 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{OH}	Output High Voltage; NOTE 1		V_{CCO_B} - 1.4		V_{CCO_B} - 0.9	V
V_{OL}	Output Low Voltage; NOTE 1		V_{CCO_B} - 2.0		V_{CCO_B} - 1.7	V
V_{SWING}	Peak-to-Peak Output Voltage Swing		0.6		1.0	V

NOTE 1: Outputs terminated with 50Ω to V_{CCO_B} - 2V.

TABLE 5. CRYSTAL CHARACTERISTICS

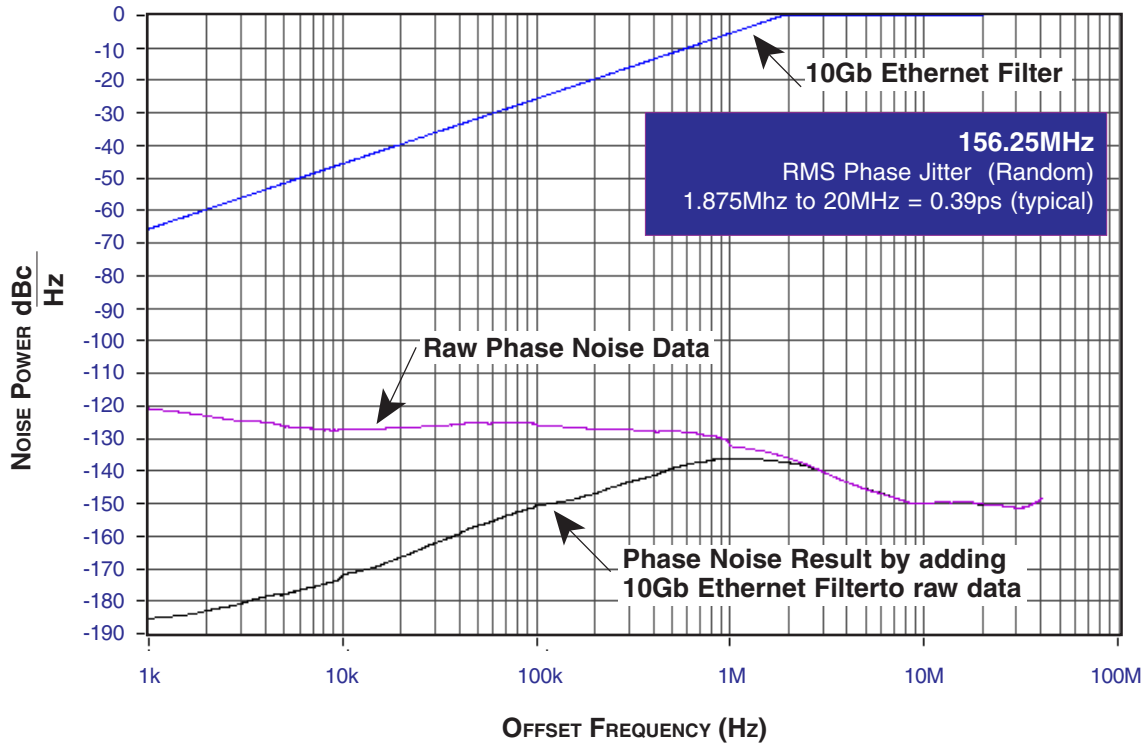| Parameter	Test Conditions	Minimum	Typical	Maximum	Units
Mode of Oscillation			Fundamental		
Frequency			25		MHz
Equivalent Series Resistance (ESR)				50	Ω
Shunt Capacitance				7	pF
Drive Level				1	mW

NOTE: Characterized using an 18pF parallel resonant crystal.

TABLE 6. AC CHARACTERISTICS, $V_{CC} = V_{CCA} = V_{CCO\_A,}$ $V_{CCO\_B} = 3.3V\pm5\%$, TA = 0°C TO 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
f_{OUT}	Output Frequency Range				156.25		MHz
					125		MHz
$t\text{jit}(\varnothing)$	RMS Phase Jitter (Random); NOTE 1	QA	125MHz (1.875MHz - 20MHz)		0.41		ps
		QB, nQB	156.25MHz (1.875MHz - 20MHz)		0.39		ps
t_R / t_F	Output Rise/Fall Time	QA	20% to 80%	500		1200	ps
		QB, nQB		300		700	ps
odc	Output Duty Cycle	QA		47		53	%
		QB, nQB		48		52	%

NOTE 1: Please refer to the Phase Noise Plots.

TYPICAL PHASE NOISE AT 156.25MHz

10Gb Ethernet Filter

156.25MHz
RMS Phase Jitter (Random)
1.875Mhz to 20MHz = 0.39ps (typical)

Raw Phase Noise Data

**Phase Noise Result by adding
10Gb Ethernet Filterto raw data**

NOISE POWER dBc/Hz

OFFSET FREQUENCY (Hz)

TYPICAL PHASE NOISE AT 125MHz

10Gb Ethernet Filter

125MHz
RMS Phase Jitter (Random)
1.875Mhz to 20MHz = 0.41ps (typical)

Raw Phase Noise Data

**Phase Noise Result by adding
10Gb Ethernet Filterto raw data**

NOISE POWER dBc/Hz

OFFSET FREQUENCY (Hz)
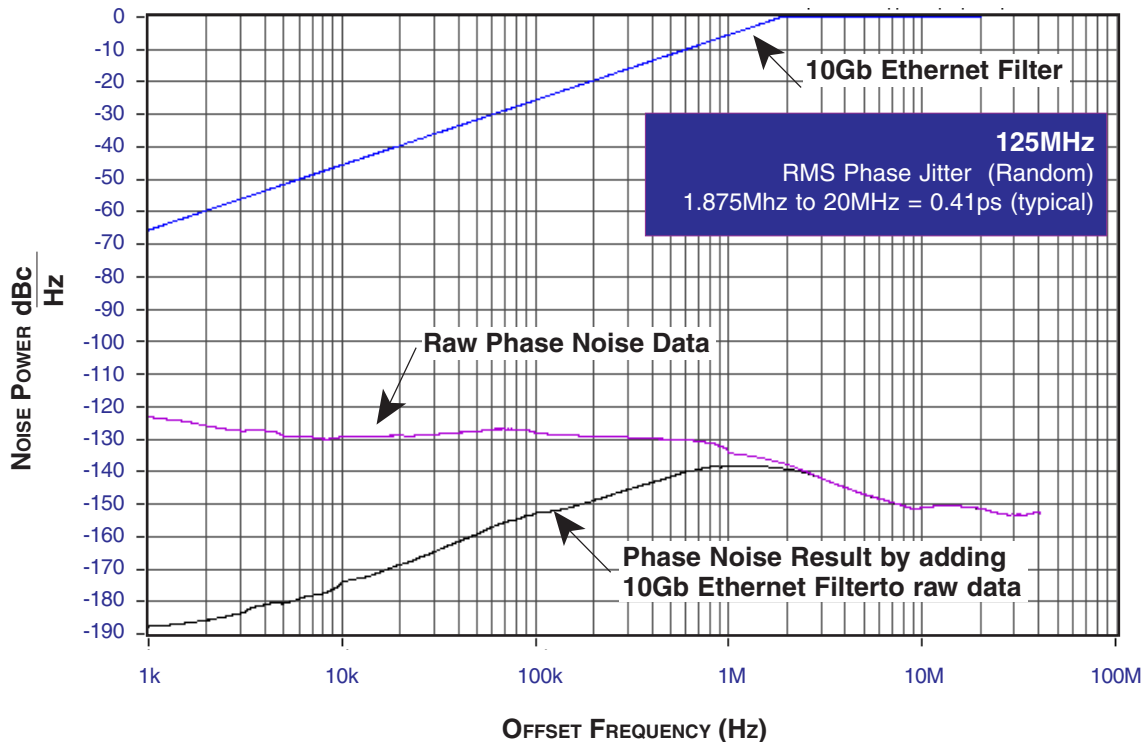
PARAMETER MEASUREMENT INFORMATION
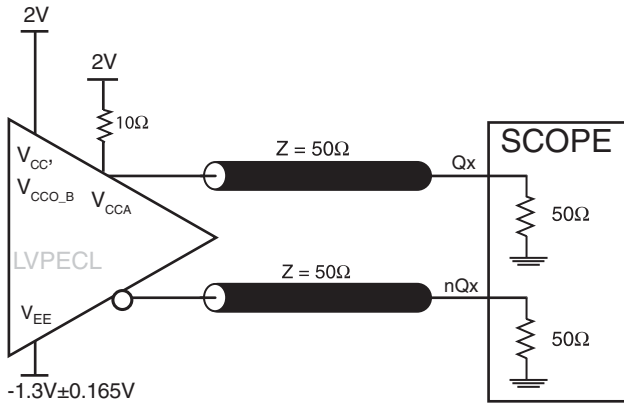
3.3V CORE/3.3V LVPECL OUTPUT LOAD AC TEST CIRCUIT
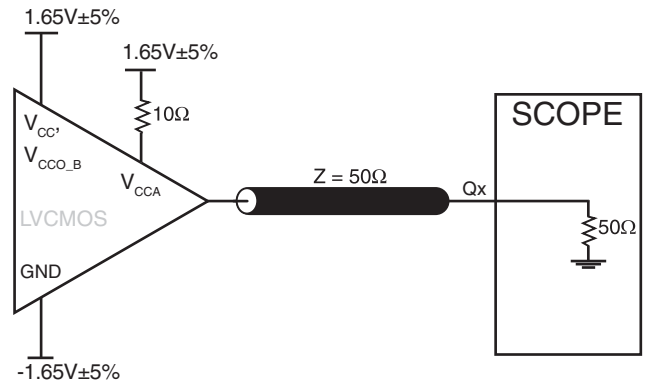
3.3V CORE/3.3V LVCMOS OUTPUT LOAD AC TEST CIRCUIT
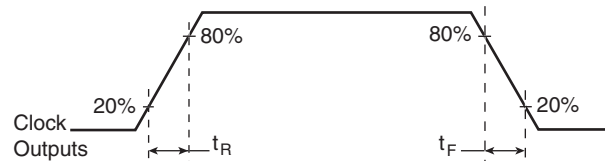
RMS PHASE JITTER

RMS Jitter = $\sqrt{\text{Area Under the Masked Phase Noise Plot}}$
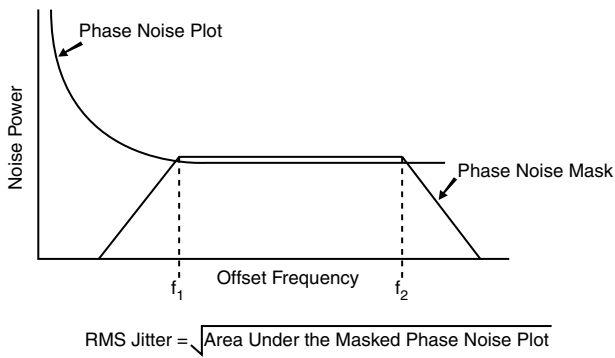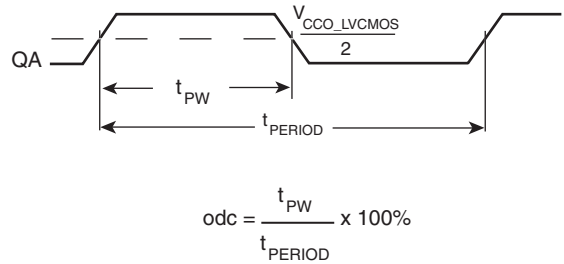
LVCMOS OUTPUT DUTY CYCLE/PULSE WIDTH/PERIOD

$$odc = \frac{t_{PW}}{t_{PERIOD}} \times 100\%$$
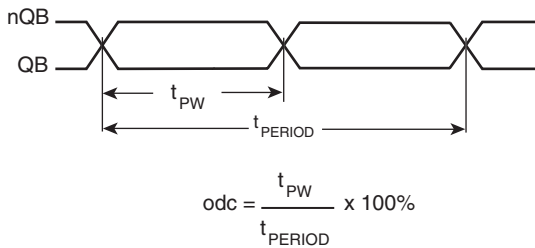
LVPECL OUTPUT DUTY CYCLE/PULSE WIDTH/PERIOD

$$odc = \frac{t_{PW}}{t_{PERIOD}} \times 100\%$$

LVCMOS OUTPUT RISE/FALL TIME
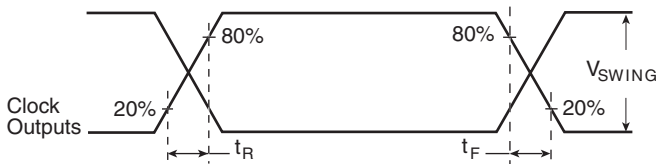
LVPECL OUTPUT RISE/FALL TIME

APPLICATION INFORMATION

POWER SUPPLY FILTERING TECHNIQUES

As in any high speed analog circuitry, the power supply pins are vulnerable to random noise. The ICS8430252-45 provides separate power supplies to isolate any high switching noise from the outputs to the internal PLL. V_{CC}, V_{CCA}, and V_{CCO_X} should be individually connected to the power supply plane through vias, and bypass capacitors should be used for each pin. To achieve optimum jitter performance, power supply isolation is required. *Figure 1* illustrates how a 10Ω resistor along with a 10µF and a .01µF bypass capacitor should be connected to each V_{CCA} pin.
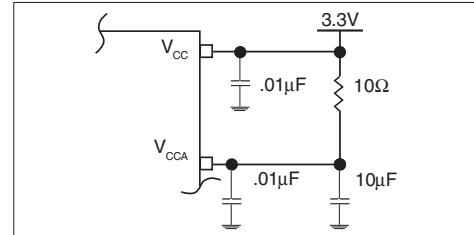

FIGURE 1. POWER SUPPLY FILTERING

RECOMMENDATIONS FOR UNUSED INPUT AND OUTPUT PINS

INPUTS:

SELECT PINS:
All select pins have internal pull-ups and pull-downs; additional resistance is not required but can be added for additional protection. A 1kΩ resistor can be used.

OUTPUTS:

LVCMOS OUTPUT:
All unused LVCMOS output can be left floating. We recommend that there is no trace attached.

LVPECL OUTPUT
All unused LVPECL outputs can be left floating. We recommend that there is no trace attached. Both sides of the differential output pair should either be left floating or terminated.

CRYSTAL INPUT INTERFACE

The ICS8430252-45 has been characterized with 18pF parallel resonant crystals. The capacitor values shown in

Figure 2 below were determined using a 25MHz, 18pF parallel resonant crystal and were chosen to minimize the ppm error.
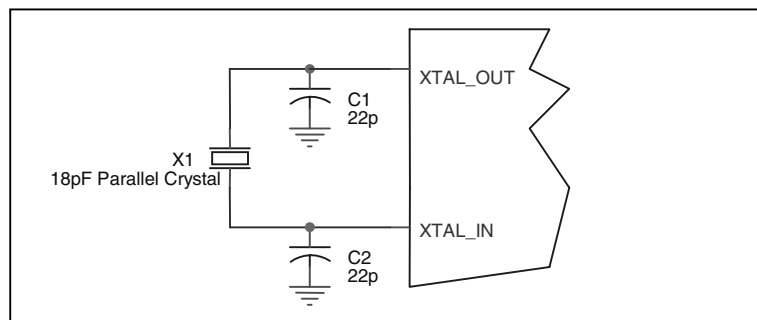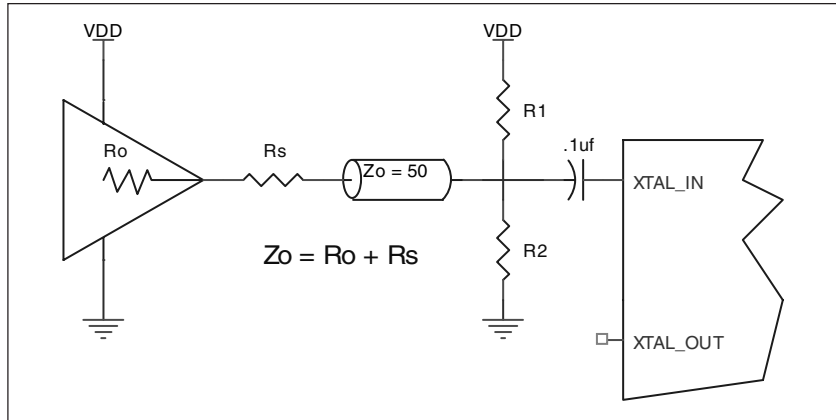

Figure 2. CRYSTAL INPUT INTERFACE

LVCMOS TO XTAL INTERFACE

The XTAL_IN input can accept a single-ended LVCMOS signal through an AC coupling capacitor. A general interface diagram is shown in *Figure X.* The XTAL_OUT pin can be left floating. The input edge rate can be as slow as 10ns. For LVCMOS inputs, it is recommended that the amplitude be reduced from full swing to half swing in order to prevent signal interference with the power rail and to reduce noise. This configuration requires that the output

impedance of the driver (Ro) plus the series resistance (Rs) equals the transmission line impedance. In addition, matched termination at the crystal input will attenuate the signal in half. This can be done in one of two ways. First, R1 and R2 in parallel should equal the transmission line impedance. For most 50Ω applications, R1 and R2 can be 100Ω. This can also be accomplished by removing R1 and making R2 50Ω.
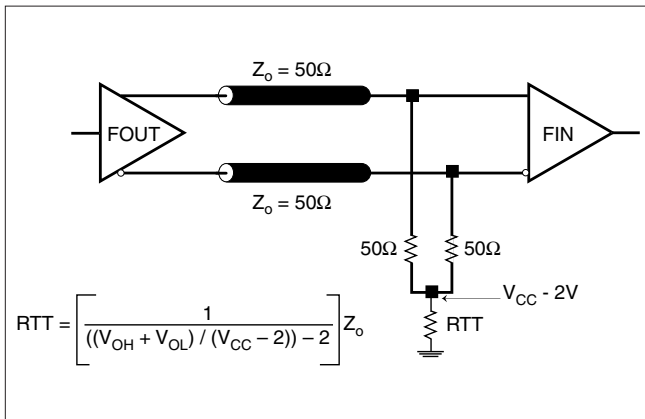

FIGURE 3. GENERAL DIAGRAM FOR LVCMOS DRIVER TO XTAL INPUT INTERFACE
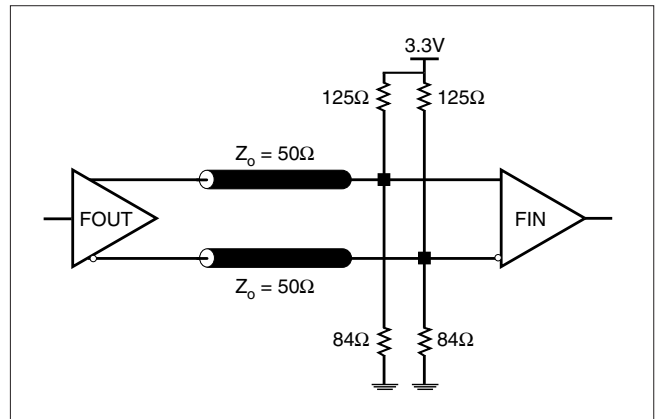
TERMINATION FOR 3.3V LVPECL OUTPUT

The clock layout topology shown below is a typical termination for LVPECL outputs. The two different layouts mentioned are recommended only as guidelines.

FOUT and nFOUT are low impedance follower outputs that generate ECL/LVPECL compatible outputs. Therefore, terminating resistors (DC current path to ground) or current sources must be used for functionality. These outputs are

designed to drive 50Ω transmission lines. Matched impedance techniques should be used to maximize operating frequency and minimize signal distortion. *Figures 4A and 4B* show two different layouts which are recommended only as guidelines. Other suitable clock layouts may exist and it would be recommended that the board designers simulate to guarantee compatibility across all printed circuit and clock component process variations.

FIGURE 4A. LVPECL OUTPUT TERMINATION

FIGURE 4B. LVPECL OUTPUT TERMINATION

LAYOUT GUIDELINE

Figure 5 shows an example of ICS8430252-45 application schematic. In this example, the device is operated at VCC=3.3V. The 18pF parallel resonant 25MHz crystal is used. The C1 = 22pF and C2 = 22pF are recommended for frequency accuracy. For different board layout, the C1 and C2 may be slightly adjusted for optimizing frequency accuracy. Two examples of LVPECL and one example of LVCMOS terminations are shown in this schematic. Additional termination approaches are shown in the LVPECL Termination Application Note.

FIGURE 5. ICS8430252-45 SCHEMATIC EXAMPLE

POWER CONSIDERATIONS

This section provides information on power dissipation and junction temperature for the ICS8430252-45.
Equations and example calculations are also provided.

1. Power Dissipation.
The total power dissipation for the ICS8430252-45 is the sum of the core power plus the power dissipated in the load(s).
The following is the power dissipation for V_{cc} = 3.3V + 5% = 3.465V, which gives worst case results.
NOTE: Please refer to Section 3 for details on calculating power dissipated in the load.

- Power (core)$_{MAX}$ = V_{CC_MAX} * I_{EE_MAX} = 3.465V * 95mA = **329.17mW**

    (95mA includes the LVCMOS output terminated with 50Ω to V_{cc}/2 at 125MHz)

- Power (outputs)$_{MAX}$ = **30mW/Loaded Output pair**

    Total Power$_{MAX}$ (3.465V, with all outputs switching) = 329.17mW + 30mW = **359.17mW**

2. Junction Temperature.
Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad and directly affects the reliability of the device. The maximum recommended junction temperature for HiPerClockS™ devices is 125°C.

   The equation for Tj is as follows: Tj = θ_{JA} * Pd_total + T_A

   Tj = Junction Temperature

   θ_{JA} = Junction-to-Ambient Thermal Resistance

   Pd_total = Total Device Power Dissipation (example calculation is in section 1 above)

   T_A = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance θ_{JA} must be used. Assuming a moderate air flow of 200 linear feet per minute and a multi-layer board, the appropriate value is 81.8°C/W per Table 7 below.

Therefore, Tj for an ambient temperature of 70°C with all outputs switching is:
   70°C + 0.359W * 81.8°C/W = 99.4°C. This is well below the limit of 125°C.

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow, and the type of board (single layer or multi-layer).

TABLE 7. THERMAL RESISTANCE θ_{JA} FOR 16-PIN TSSOP, FORCED CONVECTION

θ_{JA} by Velocity (Linear Feet per Minute)		
0	**200**	**500**
Single-Layer PCB, JEDEC Standard Test Boards 137.1°C/W	118.2°C/W	106.8°C/W
Multi-Layer PCB, JEDEC Standard Test Boards 89.0°C/W	81.8°C/W	78.1°C/W

NOTE: Most modern PCB designs use multi-layered boards. The data in the second row pertains to most designs.

3. Calculations and Equations.
The purpose of this section is to derive the power dissipated into the load.
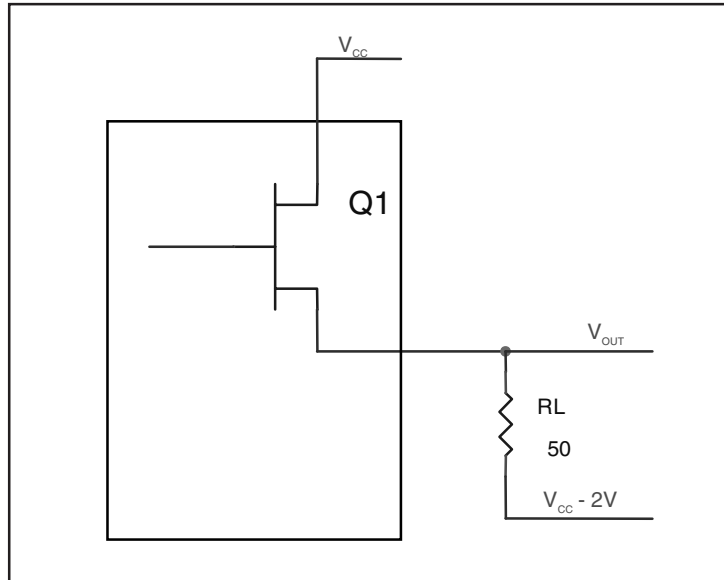LVPECL output driver circuit and termination are shown in *Figure 6.*

FIGURE 6. LVPECL DRIVER CIRCUIT AND TERMINATION

To calculate worst case power dissipation into the load, use the following equations which assume a 50Ω load, and a termination voltage of V_{cc} - 2V.

- For logic high, $V_{OUT} = V_{OH\_MAX} = \mathbf{V_{CC\_MAX} - 0.9V}$

  $(V_{CCO\_MAX} - V_{OH\_MAX}) = \mathbf{0.9V}$

- For logic low, $V_{OUT} = V_{OL\_MAX} = \mathbf{V_{CC\_MAX} - 1.7V}$

  $(V_{CCO\_MAX} - V_{OL\_MAX}) = \mathbf{1.7V}$

Pd_H is power dissipation when the output drives high.
Pd_L is the power dissipation when the output drives low.

$Pd\_H = [(V_{OH\_MAX} - (V_{CC\_MAX} - 2V))/R_L] * (V_{CC\_MAX} - V_{OH\_MAX}) = [(2V - (V_{CC\_MAX} - V_{OH\_MAX}))/R_L] * (V_{CC\_MAX} - V_{OH\_MAX}) =$
$[(2V - 0.9V)/50Ω] * 0.9V = \mathbf{19.8mW}$

$Pd\_L = [(V_{OL\_MAX} - (V_{CC\_MAX} - 2V))/R_L] * (V_{CC\_MAX} - V_{OL\_MAX}) = [(2V - (V_{CC\_MAX} - V_{OL\_MAX}))/R_L] * (V_{CC\_MAX} - V_{OL\_MAX}) =$
$[(2V - 1.7V)/50Ω] * 1.7V = \mathbf{10.2mW}$

Total Power Dissipation per output pair = Pd_H + Pd_L = **30mW**

RELIABILITY INFORMATION

TABLE 8. θ_{JA} VS. AIR FLOW TABLE FOR 16 LEAD TSSOP

θ_{JA} by Velocity (Linear Feet per Minute)			
	0	**200**	**500**
Single-Layer PCB, JEDEC Standard Test Boards	137.1°C/W	118.2°C/W	106.8°C/W
Multi-Layer PCB, JEDEC Standard Test Boards	89.0°C/W	81.8°C/W	78.1°C/W

NOTE: Most modern PCB designs use multi-layered boards. The data in the second row pertains to most designs.

TRANSISTOR COUNT

The transistor count for ICS8430252-45 is: 2070
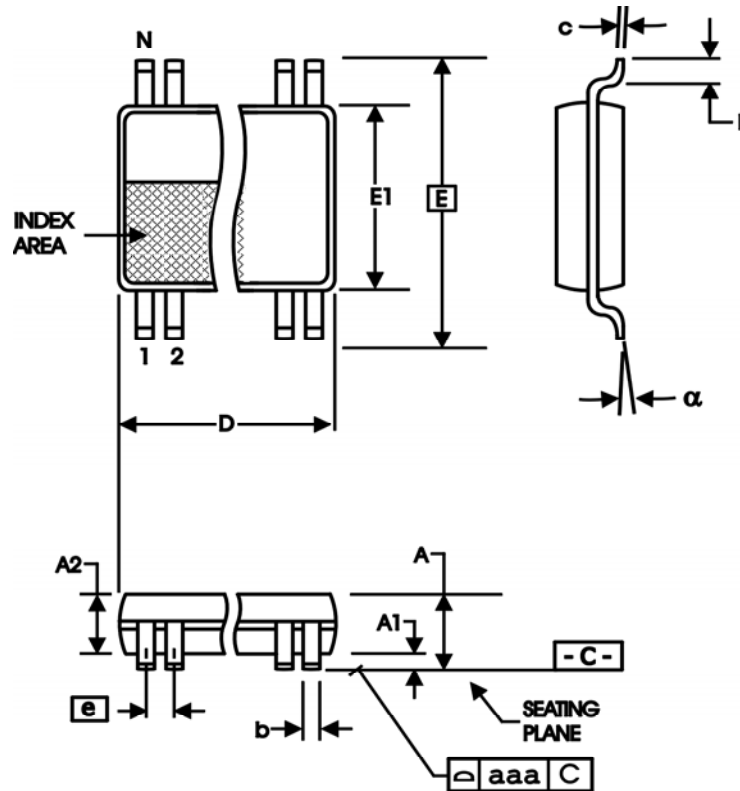
PACKAGE OUTLINE - G SUFFIX FOR 16 LEAD TSSOP

TABLE 9. PACKAGE DIMENSIONS

SYMBOL	Millimeters	
	Minimum	Maximum
N	16	
A	--	1.20
A1	0.05	0.15
A2	0.80	1.05
b	0.19	0.30
c	0.09	0.20
D	4.90	5.10
E	6.40 BASIC	
E1	4.30	4.50
e	0.65 BASIC	
L	0.45	0.75
α	0°	8°
aaa	--	0.10

Reference Document: JEDEC Publication 95, MO-153

TABLE 10. ORDERING INFORMATION

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
ICS8430252CG-45	30252C45	16 Lead TSSOP	tube	0°C to 70°C
ICS8430252CG-45T	30252C45	16 Lead TSSOP	2500 tape & reel	0°C to 70°C
ICS8430252CG-45LF	0252C45L	16 Lead "Lead-Free" TSSOP	tube	0°C to 70°C
ICS8430252CG-45LFT	0252C45L	16 Lead "Lead-Free" TSSOP	2500 tape & reel	0°C to 70°C

NOTE: Parts that are ordered with an "LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.

REVISION HISTORY SHEET				
Rev	Table	Page	Description of Change	Date
A		9	Added Schematic Layout and Guideline.	10/4/06

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